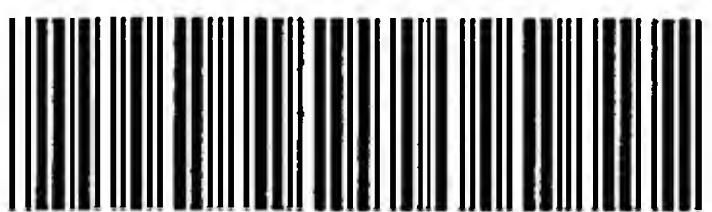


Search Notes



Application/Control No.

10/708.207

Examiner

Sung H. Pak

**Applicant(s)/Patent under
Reexamination**

LEE ET AL.

Art Unit

2874

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)